Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/936,727	MIYOSHI ET AL.	
Examiner	Art Unit	
Krista M. Flanagan	2631	

SEARCHED				
Class	Subclass	Date	Examiner	
375	144, 148, 346	12/2/2004	KMF	
370	286,342	12/2/2004	KMF	
370	441	12/2/2004	KMF	
375	130,142	12/10/2004	KMF	
375	147,150	12/10/2004	KMF	
375	144 148	5/4/2005	KMF	
375	152 346	5/4/2005	KMF	
370	286 342	5/4/2005	KMF	
		•		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	148	5/4/2005	KMF	
375	144	5/4/2005	KMF	
375	346	5/4/2005	KMF	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East [(signal data symbol pulse) same (replica\$3 copy) same (cancel\$3 remove\$3) near5 (interference\$3 noise) and despread\$3]	12/2/2004	KMF
Inventorship	11/17/2004	KMF
Updated Search	5/4/2005	KMF